Search Notes

Application/Control N		Applicant(s)/Patent under Reexamination	
10/517,316	TANAKA ET	TANAKA ET AL.	
Examiner	Art Unit		
Nam V. Nguyen	2612		

SEARCHED					
Class	Subclass	Date	Examiner		
340	10.1	11/1/07	NN		
340	10.2	11/1/2007	NN		
340	10.31	11/1/2007	NN		
340	10.51	11/1/2007	NN		
340	10.32	11/1/2007	NN		
340	10.42	11/1/2007	NN		
340	572.4	11/1/2007	NN .		
340	825.69	11/1/2007	NN		
340	825.72	11/1/2007	NN		
342	42, 44	11/1/2007	NN		
235	375	11/1/2007	NN		
370	437	11/1/2007	NN		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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		SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR				
Search EAST: USPAT; US-PUB; EPO; JPO and Derwent.	11/1/07	NN				
Search TERMS: rfids, tags or transponders with range distance readings, zones, and twice.	11/1/2007	NN				
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